

# IRF7811AVPbF

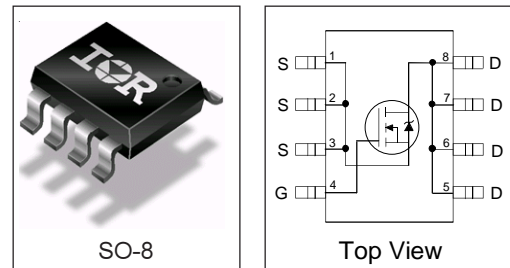
- N-Channel Application-Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Minimizes Parallel MOSFETs for high current applications
- 100% R<sub>G</sub> Tested
- Lead-Free

## Description

This new device employs advanced HEXFET Power MOSFET technology to achieve an unprecedented balance of on-resistance and gate charge. The reduced conduction and switching losses make it ideal for high efficiency DC-DC converters that power the latest generation of microprocessors.

The IRF7811AV has been optimized for all parameters that are critical in synchronous buck converters including R<sub>DS(on)</sub>, gate charge and C<sub>dv/dt</sub>-induced turn-on immunity. The IRF7811AV offers an extremely low combination of Q<sub>sw</sub> & R<sub>DS(on)</sub> for reduced losses in both control and synchronous FET applications.

The package is designed for vapor phase, infra-red, convection, or wave soldering techniques. Power dissipation of greater than 2W is possible in a typical PCB mount application.



## DEVICE CHARACTERISTICS<sup>⑤</sup>

	IRF7811AV
R <sub>DS(on)</sub>	11 mΩ
Q <sub>G</sub>	17 nC
Q <sub>sw</sub>	6.7 nC
Q <sub>oss</sub>	8.1 nC

## Absolute Maximum Ratings

Parameter	Symbol	IRF7811AV	Units
Drain-to-Source Voltage	V <sub>DS</sub>	30	V
Gate-to-Source Voltage	V <sub>GS</sub>	±20	
Continuous Output Current (V <sub>GS</sub> ≥ 4.5V)	I <sub>D</sub>	T <sub>A</sub> = 25°C	10.8
		T <sub>L</sub> = 90°C	11.8
Pulsed Drain Current <sup>①</sup>	I <sub>DM</sub>	100	
Power Dissipation <sup>③</sup>	P <sub>D</sub>	T <sub>A</sub> = 25°C	2.5
		T <sub>L</sub> = 90°C	3.0
Junction & Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Continuous Source Current (Body Diode)	I <sub>S</sub>	2.5	A
Pulsed Source Current <sup>①</sup>	I <sub>SM</sub>	50	

## Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>②⑥</sup>	R <sub>θJA</sub>	—	50	°C/W
Maximum Junction-to-Lead <sup>⑥</sup>	R <sub>θJL</sub>	—	20	

## Electrical Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	30	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
Static Drain-to-Source On-Resistance	$R_{DS(on)}$	—	11	14	m $\Omega$	$V_{GS} = 4.5V, I_D = 15A$ ②
Gate Threshold Voltage	$V_{GS(th)}$	1.0	—	3.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
Drain-to-Source Leakage Current	$I_{DSS}$	—	—	50	$\mu A$	$V_{DS} = 30V, V_{GS} = 0V$
		—	—	20	$\mu A$	$V_{DS} = 24V, V_{GS} = 0V$
		—	—	100	mA	$V_{DS} = 24V, V_{GS} = 0V, T_J = 100^\circ C$
Gate-to-Source Leakage Current	$I_{GSS}$	—	—	$\pm 100$	nA	$V_{GS} = \pm 20V$
Total Gate Charge, Control FET	$Q_g$	—	17	26	nC	$V_{DS} = 24V, I_D = 15A, V_{GS} = 5.0V$
Total Gate Charge, Synch FET	$Q_g$	—	14	21	nC	$V_{GS} = 5.0V, V_{DS} < 100mV$
Pre-V <sub>th</sub> Gate-to-Source Charge	$Q_{gs1}$	—	3.4	—	nC	$V_{DS} = 16V, I_D = 15A$
Post-V <sub>th</sub> Gate-to-Source Charge	$Q_{gs2}$	—	1.6	—	nC	
Gate-to-Drain ("Miller") Charge	$Q_{gd}$	—	5.1	—	nC	
Switch Charge ( $Q_{gs2} + Q_{gd}$ )	$Q_{SW}$	—	6.7	—	nC	
Output Charge	$Q_{OSS}$	—	8.1	12	nC	
Gate Resistance	$R_G$	0.5	—	4.4	$\Omega$	$V_{DS} = 16V, V_{GS} = 0$
Turn-On Delay Time	$t_{d(on)}$	—	8.6	—	ns	$V_{DD} = 16V$ $I_D = 15A$ $V_{GS} = 5.0V$ Clamped Inductive Load
Rise Time	$t_r$	—	21	—	ns	
Turn-Off Delay Time	$t_{d(off)}$	—	43	—	ns	
Fall Time	$t_f$	—	10	—	ns	
Input Capacitance	$C_{iss}$	—	1801	—	pF	$V_{GS} = 0V$
Output Capacitance	$C_{oss}$	—	723	—	pF	$V_{DS} = 10V$
Reverse Transfer Capacitance	$C_{rss}$	—	46	—	pF	

## Diode Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Diode Forward Voltage	$V_{SD}$	—	—	1.3	V	$T_J = 25^\circ C, I_S = 15A$ ②, $V_{GS} = 0V$
Reverse Recovery Charge ④	$Q_{rr}$	—	50	—	nC	$di/dt = 700A/\mu s$ $V_{DD} = 16V, V_{GS} = 0V, I_D = 15A$
Reverse Recovery Charge (with Parallel Schottsky) ④	$Q_{rr}$	—	43	—	nC	$di/dt = 700A/\mu s$ , (with 10BQ040) $V_{DD} = 16V, V_{GS} = 0V, I_D = 15A$

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ③ When mounted on 1 inch square copper board,  $t < 10$  sec.
- ④ Typ = measured -  $Q_{oss}$
- ⑤ Typical values of  $R_{DS(on)}$  measured at  $V_{GS} = 4.5V$ ,  $Q_g$ ,  $Q_{SW}$  and  $Q_{OSS}$  measured at  $V_{GS} = 5.0V$ ,  $I_F = 15A$ .
- ⑥  $R_{\theta}$  is measured at  $T_J$  approximately  $90^\circ C$

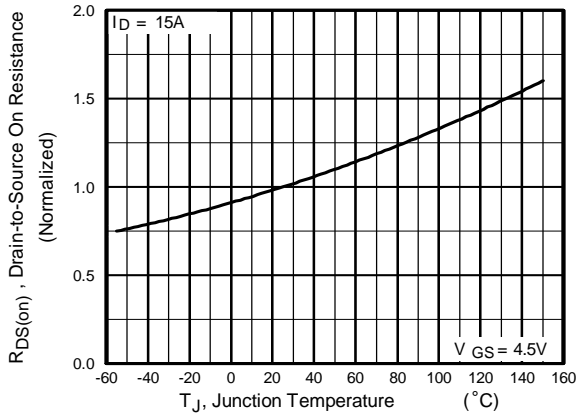


Figure 1. Normalized On-Resistance vs. Temperature

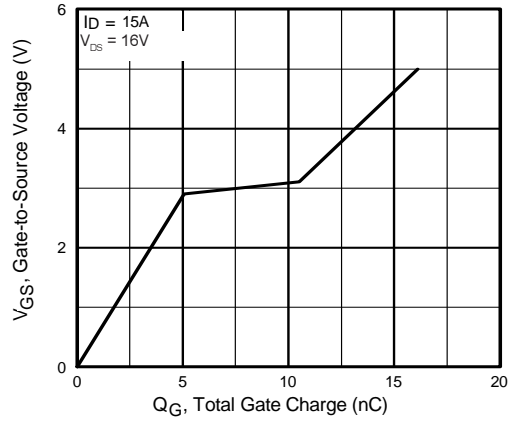


Figure 2. Gate-to-Source Voltage vs. Typical Gate Charge

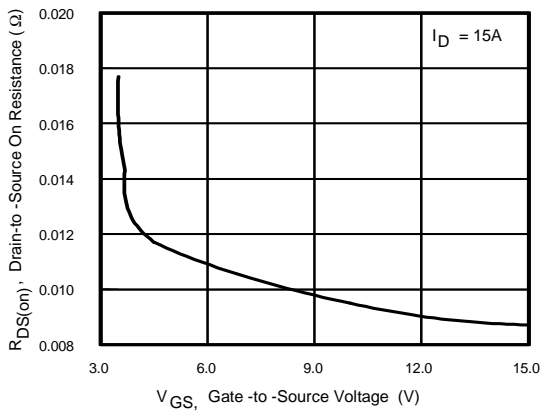


Figure 3. Typical  $R_{DS(on)}$  vs. Gate-to-Source Voltage

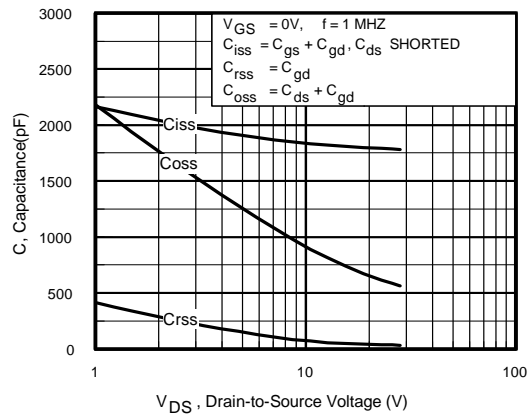


Figure 4. Typical Capacitance vs. Drain-to-Source Voltage

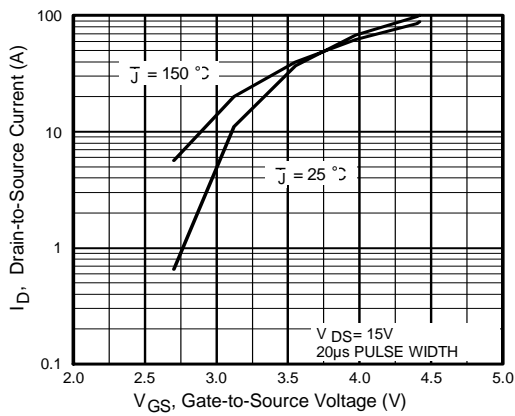


Figure 5. Typical Transfer Characteristics

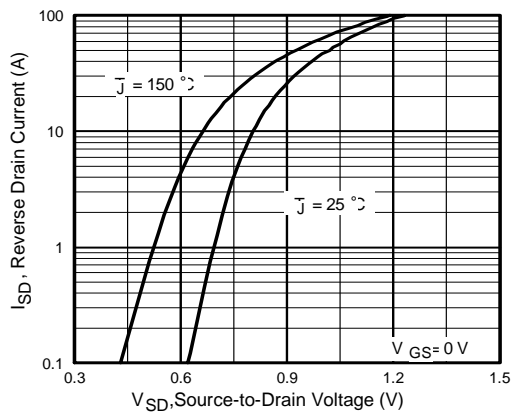


Figure 6. Typical Source-Drain Diode Forward Voltage

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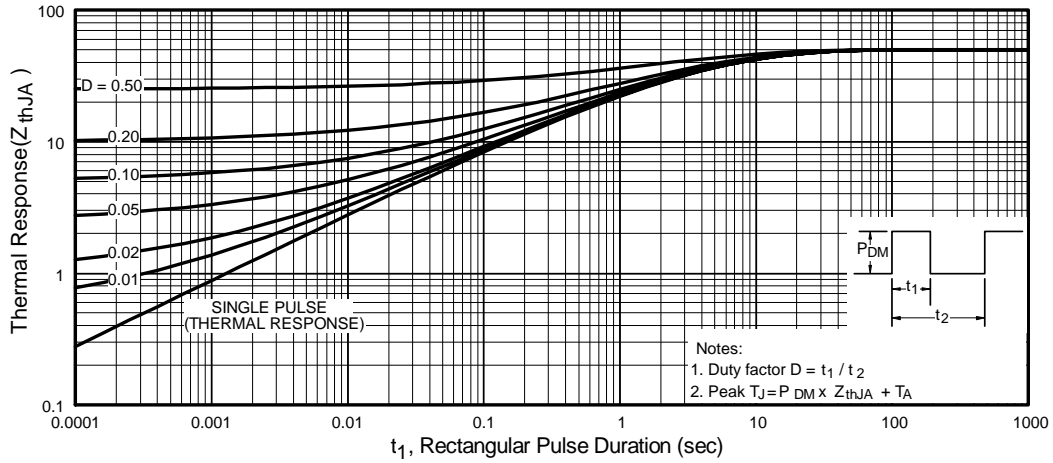


Figure 7. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

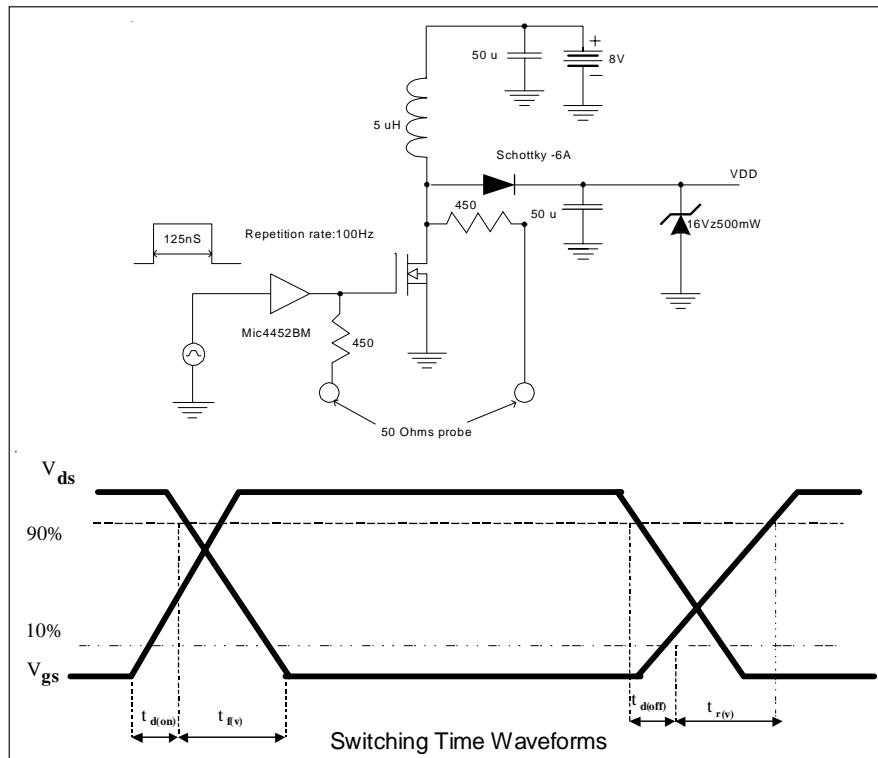
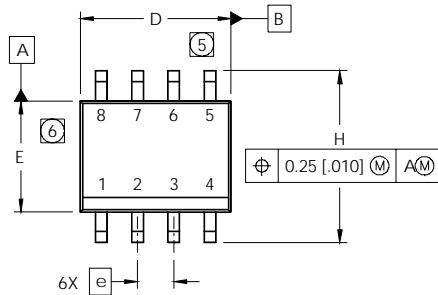


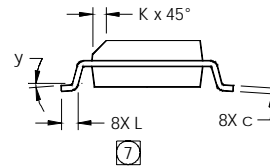
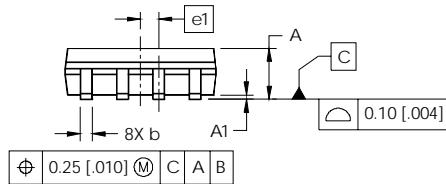
Figure 8. Clamped Inductive load test diagram and switching waveform

## SO-8 Package Outline

Dimensions are shown in millimeters (inches)



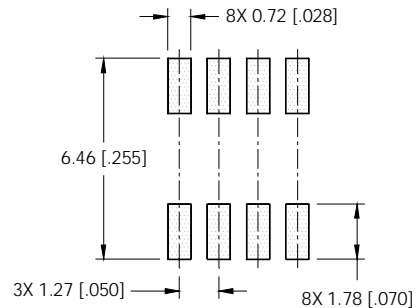
DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°



NOTES:

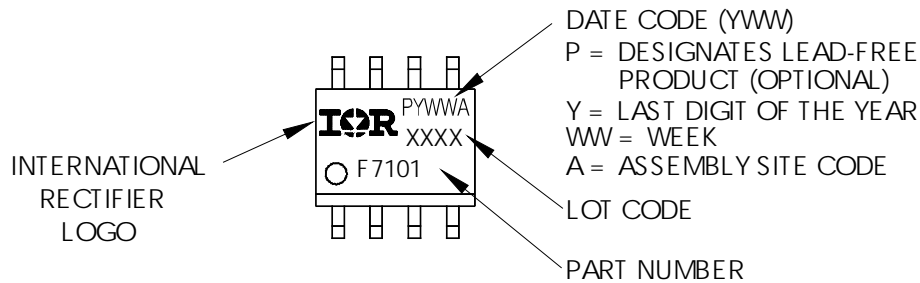
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

FOOTPRINT



## SO-8 Part Marking

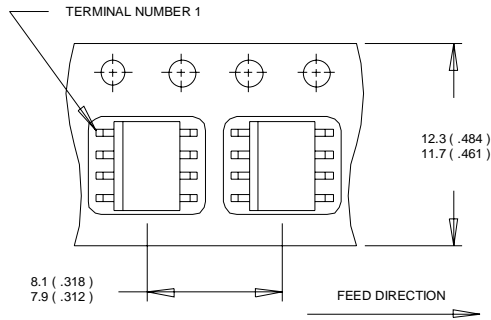
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



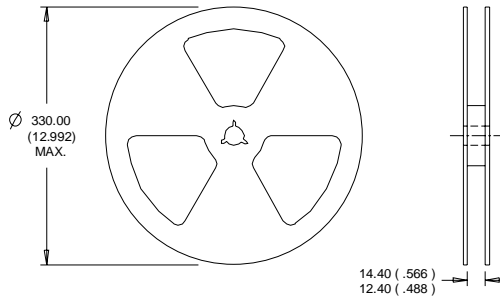
# IRF7811AVPbF

International  
**IR** Rectifier

## SO-8 Tape and Reel



- NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualifications Standards can be found on IR's Web site.

International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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